

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 09/744,084 LAPPE ET AL.	
		Examiner	Art Unit	Page 1 of 1 Anthony T Ton 2661

U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-5,533,012 A	07-1996	Fukasawa et al.	370/342
B	US-5,377,194 A	12-1994	Calderbank, Arthur R.	370/524
C	US-6,256,497 B1	07-2001	Chambers, Paul	455/433
D	US-6,134,220 A	10-2000	Le Strat et al.	370/252
E	US-6,339,601 B1	01-2002	Seong et al.	370/503
F	US-5,689,245	11-1997	Noreen et al.	340/825.49
G	US-6,021,518 A	02-2000	Pelz, Rodolfo Mann	714/799
H	US-5,687,165	11-1997	Daffara et al.	370/208
I	US-5,701,294	12-1997	Ward et al.	370/252
J	US-6,112,084	08-2000	Sicher et al.	370/337
K	US-6,016,428	01-2000	Diachina et al.	455/435.1
L	US-5,729,531	03-1998	Raith et al.	370/252
M	US-5,757,813	05-1998	Raith, Alex Krister	714/708

FOREIGN PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
O					
P					
Q					
R					
S					
T					

NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
U	
V	
W	
X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.